

# 12-Bit ADC in 6-Lead SOT-23

# AD7476-EP

### **FEATURES**

Specified for V<sub>DD</sub> of 2.35 V to 5.25 V Low power 3.6 mW at 600 kSPS with 3 V supplies 15 mW at 600 kSPS with 5 V supplies Wide input bandwidth 70 dB SNR at 100 kHz input frequency High speed serial interface SPI/QSPI™/MICROWIRE™/DSP compatible Standby mode: 1 µA maximum 6-lead SOT-23 package

### ENHANCED PRODUCT FEATURES

Military temperature range (-55°C to +125°C) Controlled manufacturing baseline One assembly/test site One fabrication site Enhanced product change notification Qualification data available upon request

### **APPLICATIONS**

Battery-powered systems Personal digital assistants Medical instruments Mobile communications Instrumentation and control systems Data acquisition systems

### **GENERAL DESCRIPTION**

The AD7476<sup>1</sup> is a 12-bit, high speed, low power, successive approximation ADC. The part operates from a single 2.35 V to 5.25 V power supply and features throughput rates up to 600 kSPS. The part contains a low noise, wide bandwidth, track-and-hold amplifier that can handle input frequencies in excess of 6 MHz.

The conversion process and data acquisition are controlled using  $\overline{CS}$  and the serial clock, allowing the device to interface with microprocessors or DSPs. The input signal is sampled on the falling edge of  $\overline{CS}$  and the conversion is initiated at this point. There are no pipeline delays associated with this part.

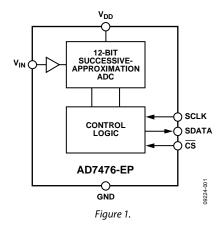
The AD7476 uses advanced design techniques to achieve very low power dissipation at high throughput rates.

<sup>1</sup> Protected by U.S. Patent No. 6,681,332.

#### Rev. 0

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### FUNCTIONAL BLOCK DIAGRAM



The reference for the part is taken internally from  $V_{DD}$ . This allows the widest dynamic input range to the ADC. Thus, the analog input range for the part is 0 V to  $V_{DD}$ . The conversion rate is determined by the SCLK pin.

Additional application and technical information can be found in the AD7476 data sheet.

### **PRODUCT HIGHLIGHTS**

- 1. First 12-Bit ADC in a SOT-23 Package.
- 2. High Throughput with Low Power Consumption.
- 3. Flexible Power/Serial Clock Speed Management. The conversion rate is determined by the serial clock, allowing the conversion time to be reduced through the serial clock speed increase. This allows the average power consumption to be reduced while not converting. The part also features a shutdown mode to maximize power efficiency at lower throughput rates. Current consumption is 1 μA maximum when in shutdown mode.
- 4. Reference Derived from the Power Supply.
- 5. No Pipeline Delay. The part features a standard successiveapproximation ADC with accurate control of the sampling instant via a  $\overline{CS}$  input and once-off conversion control.

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### **REVISION HISTORY**

8/10—Revision 0: Initial Version

### **SPECIFICATIONS**

 $V_{DD}$  = 2.35 V to 5.25 V,  $f_{SCLK}$  = 12 MHz,  $f_{SAMPLE}$  = 600 kSPS, unless otherwise noted;  $T_A = T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.

### Table 1.

Parameter	S Version	Unit	Test Conditions/Comments	
DYNAMIC PERFORMANCE			f <sub>IN</sub> = 100 kHz sine wave	
Signal-to-(Noise + Distortion) (SINAD)	69	dB min		
	70	dB min	$T_A = 25^{\circ}C$	
Signal-to-Noise Ratio (SNR)	70	dB min		
Total Harmonic Distortion (THD)	-78	dB typ		
Peak Harmonic or Spurious Noise (SFDR)	-80	dB typ		
Intermodulation Distortion (IMD)				
Second-Order Terms	-78	dB typ	fa = 103.5 kHz, fb = 113.5 kHz	
Third-Order Terms	-78	dB typ	fa = 103.5 kHz, fb = 113.5 kHz	
Aperture Delay	10	ns typ		
Aperture Jitter	30	ps typ		
Full Power Bandwidth	6.5	MHz typ	At 3 dB	
DC ACCURACY			$V_{DD} = (2.35 \text{ V to } 3.6 \text{ V})^1$	
Resolution	12	Bits		
Integral Nonlinearity	±1.5	LSB max		
5	±0.6	LSB typ		
Differential Nonlinearity	-0.9/+1.5	LSB max	Guaranteed no missed codes to 12 bits	
	±0.75	LSB typ		
Offset Error	±2	LSB max		
		LSB typ		
Gain Error	±2	LSB max		
		LSB typ		
ANALOG INPUT				
Input Voltage Ranges	0 to V <sub>DD</sub>	V		
DC Leakage Current	±1	µA max		
Input Capacitance	30	pF typ		
LOGIC INPUT				
Input High Voltage, V <sub>INH</sub>	2.4	V min		
	1.8	V min	$V_{DD} = 2.35 V$	
Input Low Voltage, VINL	0.4	V max	$V_{DD} = 3 V$	
	0.8	V max	$V_{DD} = 5 V$	
Input Current, I <sub>IN</sub> , SCLK Pin	±1	µA max	Typically 10 nA, $V_{IN} = 0$ V or $V_{DD}$	
Input Current, I <sub>IN</sub> , CS Pin	±1	μA typ		
Input Capacitance, C <sub>IN</sub> <sup>2</sup>	10	pF max		
LOGIC OUTPUT		рі пах		
Output High Voltage, V <sub>OH</sub>	V <sub>DD</sub> - 0.2	V min	$I_{SOURCE} = 200 \ \mu A; V_{DD} = 2.35 \ V \ to \ 5.25 \ V$	
Output Low Voltage, Vol	0.4	V max	$I_{SOURCE} = 200 \ \mu A$	
Floating-State Leakage Current	±10	μA max		
Floating-State Output Capacitance <sup>2</sup>	10	pF max		
Output Coding	Straight (natural) binary			
CONVERSION RATE	Straight (natural) bindly			
CONVERSION RATE Conversion Time	1 22	us may	16 SCLK cyclor	
Track-and-Hold Acquisition Time	1.33 500	µs max	16 SCLK cycles	
		ns max	Full-scale step input	
Throughout Data	400	ns max	Sine wave input ≤ 100 kHz	
Throughput Rate	600	kSPS max		

Parameter	S Version	Unit	Test Conditions/Comments	
POWER REQUIREMENTS				
V <sub>DD</sub>	2.35/5.25	V min/max		
I <sub>DD</sub>			Digital I/Ps = 0 V or $V_{DD}$	
Normal Mode (Static)	2	mA typ	$V_{DD} = 4.75$ V to 5.25 V, SCLK on or off	
	1	mA typ	$V_{DD} = 2.35$ V to 3.6 V, SCLK on or off	
Normal Mode (Operational)	3	mA max	$V_{DD} = 4.75 V \text{ to } 5.25 V,$ $f_{SAMPLE} = f_{SAMPLE} MAX^3$	
	1.4	mA max	$V_{DD} = 2.35 V \text{ to } 3.6 V,$ $f_{SAMPLE} = f_{SAMPLE} MAX^4$	
Full Power-Down Mode	1	μA max	SCLK off	
	80	μA max	SCLK on	
Power Dissipation				
Normal Mode (Operational)	15	mW max	$V_{DD} = 5 \text{ V},  \text{f}_{\text{SAMPLE}} = \text{f}_{\text{SAMPLE}} \text{MAX}^4$	
	4.2	mW max	$V_{DD} = 3 V$ , $f_{SAMPLE} = f_{SAMPLE}MAX^4$	
Full Power-Down	5	μW max	$V_{DD} = 5 V$ , SCLK off	
	3	μW max	$V_{DD} = 3 V$ , SCLK off	

 $^1$  S version specifications apply as typical figures when  $V_{\text{DD}}$  = 5.25 V.  $^2$  Guaranteed by characterization.  $^3$  fs\_{AMPLe}MAX = 600 kSPS.

### **TIMING SPECIFICATIONS**

 $V_{\rm DD}$  = 2.35 V to 5.25 V,  $T_{\rm A}$  =  $T_{\rm MIN}$  to  $T_{\rm MAX},$  unless otherwise noted.

#### Table 2.

	Limit at 1	Limit at T <sub>MIN</sub> , T <sub>MAX</sub> <sup>1</sup>				
Parameter <sup>2</sup>	3 V	3V 5V		Description		
f <sub>SCLK</sub> <sup>3</sup>	10	10	kHz min			
	12	12	MHz max			
<b>t</b> convert	16 × t <sub>SCLK</sub>	16 × t <sub>SCLK</sub>				
t <sub>QUIET</sub>	50	50	ns min	Minimum quiet time required between bus relinquish and start of next conversion		
t1	10	10	ns min	Minimum CS pulse width		
t <sub>2</sub>	10	10	ns min	CS to SCLK setup time		
t <sub>3</sub> 4	20	20	ns max	Delay from CS until SDATA three-state disabled		
t4 <sup>4</sup>	40	20	ns max	Data access time after SCLK falling edge, A version		
	70	20	ns max	Data access time after SCLK falling edge, B version		
t5	$0.4  imes t_{\text{SCLK}}$	$0.4  imes t_{\text{SCLK}}$	ns min	SCLK low pulse width		
t <sub>6</sub>	$0.4  imes t_{\text{SCLK}}$	$0.4  imes t_{\text{SCLK}}$	ns min	SCLK high pulse width		
t7	10	10	ns min	SCLK to data valid hold time		
t8 <sup>5</sup>	10	10	ns min	SCLK falling edge to SDATA high impedance		
	25	25	ns max	SCLK falling edge to SDATA high impedance		
tpower-up	1	1	µs typ	Power-up time from full power-down		

<sup>1</sup> 3 V specifications apply from  $V_{DD} = 2.35$  V to 3.6 V; 5 V specifications apply from  $V_{DD} = 4.75$  V to 5.25 V. <sup>2</sup> Guaranteed by characterization. All input signals are specified with tr = tf = 5 ns (10% to 90% of  $V_{DD}$ ) and timed from a voltage level of 1.6 V.

<sup>3</sup> Mark/space ratio for the SCLK input is 40/60 to 60/40.

<sup>4</sup> Measured with the load circuit of Figure 2 and defined as the time required for the output to cross 0.8 V or 2.0 V.

<sup>5</sup> t<sub>8</sub> is derived from the measured time taken by the data output to change 0.5 V when loaded with the circuit in Figure 2. The measured number is then extrapolated to remove the effects of charging or discharging the 50 pF capacitor. This means that the time, ts, is the true bus relinquish time of the part and is independent of the bus loading.

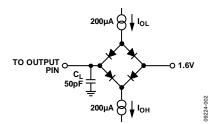


Figure 2. Load Circuit for Digital Output Timing Specifications

### **ABSOLUTE MAXIMUM RATINGS**

 $T_A = 25^{\circ}C$ , unless otherwise noted.

### Table 3.

Parameter	Rating		
V <sub>DD</sub> to GND	–0.3 V to +7 V		
Analog Input Voltage to GND	$-0.3$ V to $V_{\text{DD}}$ + 0.3 V		
Digital Input Voltage to GND	–0.3 V to +7 V		
Digital Output Voltage to GND	-0.3 V to V <sub>DD</sub> + 0.3 V		
Input Current to Any Pin Except Supplies <sup>1</sup>	±10 mA		
Operating Temperature Range			
Enhanced Plastic (EP Version)	–55°C to +125°C		
Storage Temperature Range	–65°C to +150°C		
Junction Temperature	150°C		
SOT-23 Package			
$\theta_{JA}$ Thermal Impedance	230°C/W		
θ <sub>JC</sub> Thermal Impedance	92°C/W		
Lead Temperature, Soldering Reflow			
(10 sec to 30 sec)	235 (0/+5)°C		
Pb-free Temperature Soldering Reflow	255 (0/+5)°C		
ESD	3.5 kV		

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

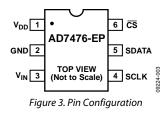
### **ESD CAUTION**



**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

<sup>1</sup> Transient currents of up to 100 mA do not cause SCR latch-up.

# **PIN CONFIGURATION AND FUNCTION DESCRIPTIONS**



### Table 4. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	V <sub>DD</sub>	Power Supply Input. The V <sub>DD</sub> range for the AD7476-EP is from 2.35 V to 5.25 V.
2	GND	Analog Ground. Ground reference point for all circuitry on the part. All analog input signals should be referred to this GND voltage.
3	V <sub>IN</sub>	Analog Input. Single-ended analog input channel. The input range is 0 V to VDD.
4	SCLK	Serial Clock. Logic input. SCLK provides the serial clock for accessing data from the part. This clock input is also used as the clock source for the AD7476-EP conversion process.
5	SDATA	Data Out. Logic output. The conversion result is provided on this output as a serial data stream. The bits are clocked out on the falling edge of the SCLK input. The data stream from the AD7476-EP consists of four leading zeros followed by the 12 bits of conversion data; this is provided MSB first.
6	<u>cs</u>	Chip Select. Active low logic input. This input provides the dual function of initiating conversions on the AD7476-EP and framing the serial data transfer.

# **TYPICAL PERFORMANCE CHARACTERISTICS**

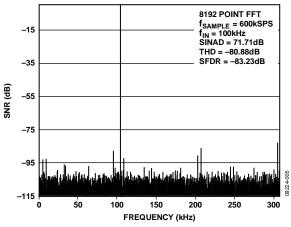


Figure 4. AD7476-EP Dynamic Performance at 600 kSPS

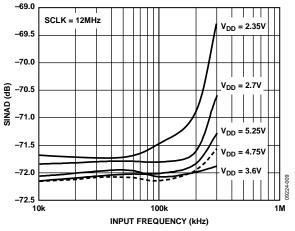
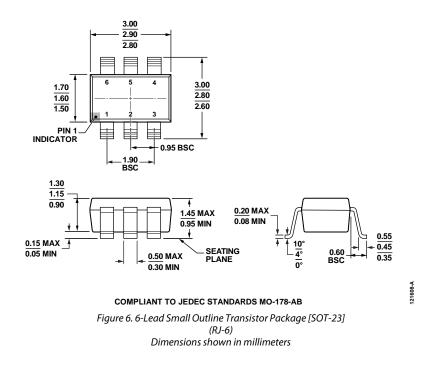


Figure 5. AD7476-EP SINAD vs. Input Frequency at 605 kSPS

### **OUTLINE DIMENSIONS**



#### **ORDERING GUIDE**

Model <sup>1</sup>	Temperature Range	Linearity Error (LSB) <sup>2</sup>	Package Description	Package Option	Branding
AD7476SRTZ-EP-RL7	-55°C to +125°C	±1.5 maximum	6-Lead SOT-23	RJ-6	C73#

<sup>1</sup> Z = RoHS Compliant Part, # denotes RoHS compliant part maybe top or bottom marked.

<sup>2</sup> Linearity error refers to integral linearity error.

# NOTES

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### **NOTES**

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